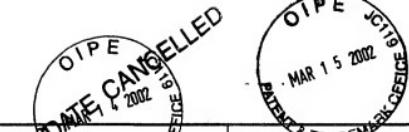


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FORM PTO-1449 (Rev. 6-2001)

LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE
STATEMENT (Use several sheets if necessary)

Attorney Docket No.: 251US

Application No.: 09/929,521

Applicant: John Hefsi et al.

Filing Date: August 13, 2001

Group: 1641

Reference Designation

U.S. PATENT DOCUMENTS

Page 1

Examiner Initial	Document No.	Date	Name	Class	Sub-class	Filing Date (If Appropriate)
AA	6,048,692	4/11/00	Marcas et al.	435	6	
AB	5,966,017	10/12/99	Scott	324	639	
AC	5,900,618	05/04/99	Anlarge et al.	250	201.3	
AD	5,858,666	01/12/99	Weiss	435	6	
AE	5,653,939	08/97	Hollis et al.	422	50	
AF	5,363,052	11/8/94	McKee	324	663	
AG	5,156,810	10/92	Ribi	422	82.01	
AH	5,025,222	06/18/91	Scott	324	639	

FOREIGN PATENT DOCUMENTS

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AI	0 519 250 A2		EP			

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AJ	Amo et al., "Dielectric Measurements of Lysozyme and Tri-N-Acetyl-D-Glucosamine Association at Radio and Microwave Frequencies", Biosensors & Bioelectronics, 12(9-10):953-958 (1997)
AK	Hollis et al., "A Swept Frequency Magnitude Method for the Dielectric Characterization of Chemical and Biological Systems", IEEE Transactions on Microwave Theory and Techniques, Vol. MTT-28, No. 7, July 1980, pgs. 791-801
AL	Esselle et al., "Capacitive sensors for in-vivo measurements of the dielectric properties of biological materials", IEEE Transactions on Instrumentation and Measurement, 37(1):101-105 (1988)
AM	Stuchly et al., "Coaxial line reflection methods for measuring dielectric properties of biological substances at radio and microwave frequencies - A review", IEEE Transactions on Instrumentation and Measurement, Vol. IM-29, No. 3, Sept. 1980, pgs. 176-183

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.